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Function, Pinout, and Drive Compatible CY54FCT244T . . . D PACKAGE CY74FCT244T ... P, Q, OR SO PACKAGE With FCT and F Logic (TOP VIEW) Reduced V<sub>OH</sub> (Typically = 3.3 V) Versions 20 VCC of Equivalent FCT Functions OE<sub>A</sub> [ 19 0EB DA<sub>0</sub> 2 Edge-Rate Control Circuitry for ОВ<sub>0</sub> 🛛 з 18 OA<sub>0</sub> Significantly Improved Noise DA1 🛛 4 DB0 17 **Characteristics** OB₁ 🛚 5 16 OA1 • Ioff Supports Partial-Power-Down Mode  $DA_2 \begin{bmatrix} 6 \\ 6 \end{bmatrix}$ 15 DB1 Operation OB<sub>2</sub> 7 14  $OA_2$ ESD Protection Exceeds JESD 22 DA3 🛛 8 13 2000-V Human-Body Model (A114-A) 12 OA3 OB3 🛛 9 200-V Machine Model (A115-A) 11 DB3 GND 🛛 10 1000-V Charged-Device Model (C101) **Matched Rise and Fall Times** CY54FCT244T . . . L PACKAGE Fully Compatible With TTL Input and (TOP VIEW) **Output Logic Levels** DEAD OEA OEB 0 B O CY54FCT244T 48-mA Output Sink Current 2 1 20 19 18 OA<sub>0</sub> 12-mA Output Source Current DA<sub>1</sub> OB<sub>1</sub>  $DB_0$ 5 17 CY74FCT244T  $DA_2$ OA<sub>1</sub> 6 16 64-mA Output Sink Current OB<sub>2</sub> 15 DB<sub>1</sub> 7 32-mA Output Source Current OA<sub>2</sub>  $DA_3$ 8 14 3-State Outputs 10 11 12 OA 3 DB 2 GND ë БВ

#### description

The 'FCT244T devices are octal buffers and line drivers designed to be employed as memory address drivers, clock drivers, and bus-oriented transmitters/receivers. These devices provide speed and drive capabilities equivalent to their fastest bipolar logic counterparts, while reducing power consumption. The input and output voltage levels allow direct interface with TTL, NMOS, and CMOS devices without external components.

These devices are fully specified for partial-power-down applications using Ioff. The Ioff circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.



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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



Copyright © 2001, Texas Instruments Incorporated On products compliant to MIL-PRF-38535, all parameters are tested unless otherwise noted. On all other products, production processing does not necessarily include testing of all parameters.

### CY54FCT244T, CY74FCT244T 8-BIT BUFFERS/LINE DRIVERS WITH 3-STATE OUTPUTS SCCS071 - OCTOBER 2001

ORDERING INFORMATION										
TA	PAC	KAGE <sup>†</sup>	SPEED (ns)	ORDERABLE PART NUMBER	TOP-SIDE MARKING					
	QSOP – Q	Tape and reel	3.6	CY74FCT244DTQCT	FCT244D					
0°C to 70°C	SOIC – SO	Tube	3.6	CY74FCT244DTSOC	FCT244D					
	5010 - 50	Tape and reel	3.6	CY74FCT244DTSOCT	FGT244D					
	SOIC – SO	Tube	4.1	CY74FCT244CTSOC	FCT244C					
	3010 - 30	Tape and reel	4.1	CY74FCT244CTSOCT	FC1244C					
	QSOP – Q	Tape and reel	4.1	CY74FCT244CTQCT	FCT244C					
	DIP – P	Tube	4.6	CY74FCT244ATPC	CY74FCT244ATPC					
-40°C to 85°C	SOIC – SO	Tube	4.6	CY74FCT244ATSOC	FCT244A					
-40 C 10 85 C	3010 - 30	Tape and reel	4.6	CY74FCT244ATSOCT	FG1244A					
	QSOP – Q	Tape and reel	4.6	CY74FCT244ATQCT	FCT244A					
	SOIC - SO	Tube	6.5	CY74FCT244TSOC	FCT244					
	3010 - 30	Tape and reel	6.5	CY74FCT244TSOCT	FG1244					
	QSOP – Q	Tape and reel	6.5	CY74FCT244TQCT	FCT244					
	CDIP – D	Tube	4.6	CY54FCT244CTDMB						
	LCC – L	Tube	4.6	CY54FCT244CTLMB						
–55°C to 125°C	CDIP – D	Tube	5.1	CY54FCT244ATDMB						
-55°C 10 125°C	LCC – L	Tube	5.1	CY54FCT244ATLMB						
	CDIP – D	Tube	7	CY54FCT244TDMB						
	LCC – L	Tube	7	CY54FCT244TLMB						

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

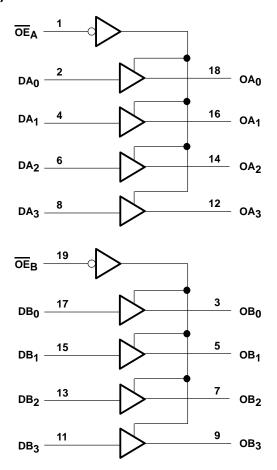
FUNCTION TABLE

	INPUTS	OUTPUT	
OEA	OEB	D	0
L	L	L	L
L	L	н	н
н	Н	Х	Z

H = High logic level, L = Low logic level, X = Don't care, Z = High-impedance state



### logic diagram (positive logic)



### absolute maximum rating over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range to ground potential	-0.5	V to 7 V
DC input voltage range	-0.5	V to 7 V
DC output voltage range	-0.5	V to 7 V $$
DC output current (maximum sink current/pin)		120 mA
Package thermal impedance, θ <sub>JA</sub> (see Note 1): P package		69°C/W
Q package		68°C/W
SO package		58°C/W
Ambient temperature range with power applied, T <sub>A</sub> 6	5°C t	o 135°C
Storage temperature range, T <sub>stg</sub> 6	5°C t	o 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51-7.



# CY54FCT244T, CY74FCT244T 8-BIT BUFFERS/LINE DRIVERS WITH 3-STATE OUTPUTS SCCS071 - OCTOBER 2001

### recommended operating conditions (see Note 2)

		CY54FCT244T			CY74FCT244DT			CY74FCT244T			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	4.75	5	5.25	4.75	5	5.25	V
VIH	High-level input voltage	2			2			2			V
VIL	Low-level input voltage			0.8			0.8			0.8	V
ЮН	High-level output current			-12			-32			-32	mA
IOL	Low-level output current			48			64			64	mA
ТА	Operating free-air temperature	-55		125	0		70	-40		85	°C

NOTE 2: All unused inputs of the device must be held at  $\mathsf{V}_{CC}$  or GND to ensure proper device operation.



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#### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

		CY	54FCT24	14T	CY	74FCT24	4T			
PARAMETER		TEST CONDITIO	NS	MIN	түр†	MAX	MIN	түр†	MAX	UNIT
N	V <sub>CC</sub> = 4.5 V,	I <sub>IN</sub> = -18 mA			-0.7	-1.2				V
VIK	V <sub>CC</sub> = 4.75 V,	I <sub>IN</sub> = -18 mA						-0.7	-1.2	v
	$V_{CC} = 4.5 V,$	I <sub>OH</sub> = -12 mA		2.4	3.3					
Vон	V <sub>CC</sub> = 4.75 V	I <sub>OH</sub> = -32 mA					2			V
	VCC = 4.75 V	I <sub>OH</sub> = -15 mA					2.4	3.3		
Ve	$V_{CC} = 4.5 V,$	I <sub>OL</sub> = 48 mA			0.3	0.55				V
VOL	V <sub>CC</sub> = 4.75 V,	I <sub>OL</sub> = 64 mA						0.3	0.55	v
V <sub>hys</sub>	All inputs				0.2			0.2		V
	V <sub>CC</sub> = 5.5 V,	$V_{IN} = V_{CC}$				5				
łı	V <sub>CC</sub> = 5.25 V,	$V_{IN} = V_{CC}$							5	μA
I	$V_{CC} = 5.5 V,$	V <sub>IN</sub> = 2.7 V				±1				μA
lΗ	$V_{CC} = 5.25 V,$	V <sub>IN</sub> = 2.7 V							±1	μА
1	$V_{CC} = 5.5 V,$				±1				μA	
۱L	V <sub>CC</sub> = 5.25 V,	V <sub>IN</sub> = 0.5 V						±1	μА	
	V <sub>CC =</sub> 5.5 V, V <sub>OUT</sub> = 2.7 V					10				μA
IOZH	$V_{CC} = 5.25 V,$	V <sub>OUT</sub> = 2.7 V							10	μА
107	$V_{CC} = 5.5 V,$	V <sub>OUT</sub> = 0.5 V				-10				μA
IOZL	V <sub>CC</sub> = 5.25 V,	V <sub>OUT</sub> = 0.5 V							-10	μΑ
los‡	$V_{CC} = 5.5 V,$	V <sub>OUT</sub> = 0 V		-60	-120	-225				mA
1051	V <sub>CC</sub> = 5.25 V,	V <sub>OUT</sub> = 0 V					-60	-120	-225	ШA
loff	$V_{CC} = 0 V,$	V <sub>OUT</sub> = 4.5 V				±1			±1	μΑ
	V <sub>CC</sub> = 5.5 V,	$V_{IN} \leq 0.2 V$ ,	$V_{IN} \ge V_{CC} - 0.2 V$		0.1	0.2				mA
ICC	V <sub>CC</sub> = 5.25 V,	$V_{IN} \leq 0.2 V$ ,	$V_{IN} \ge V_{CC} - 0.2 V$					0.1	0.2	ША
∆ICC		= 3.4 V <sup>§</sup> , f <sub>1</sub> = 0, Ou		0.5	2				mA	
	$V_{CC}$ = 5.25 V, $V_{IN}$	$= 3.4 \text{ V}\$, f_1 = 0, 0$	utputs open					0.5	2	
	$V_{CC} = 5.5 V, One i$ Outputs open, $\overline{OE}_{I}$	input switching at 5	0% duty cycle,		0.06	0.12				
	$V_{IN} \le 0.2 \text{ V or } V_{IN}$			0.00	0.12				mA/	
ICCD		$a$ input switching at $a = \overline{OE}_B = GND$ ,	50% duty cycle,					0.06	0.12	MHz

<sup>†</sup> Typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

<sup>‡</sup> Not more than one output should be shorted at a time. Duration of short should not exceed one second. The use of high-speed test apparatus and/or sample-and-hold techniques are preferable to minimize internal chip heating and more accurately reflect operational values. Otherwise, prolonged shorting of a high output can raise the chip temperature well above normal and cause invalid readings in other parametric tests. In any sequence of parameter tests,  $\mathsf{I}_{OS}$  tests should be performed last.

§ Per TTL-driven input ( $V_{IN}$  = 3.4 V); all other inputs at  $V_{CC}$  or GND

 $\P$  This parameter is derived for use in total power-supply calculations.



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#### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted) (continued)

DADAMETED	TEST CONDITIONS				54FCT24	4T	CY	74FCT24	4T	LINUT
PARAMETER		MIN	түр†	MAX	MIN	түр†	MAX	UNIT		
		One bit switching at f <sub>1</sub> = 10 MHz	$\begin{array}{l} V_{IN} \leq 0.2 \ V \ or \\ V_{IN} \geq V_{CC} - 0.2 \ V \end{array}$		0.7	1.4				
	V <sub>CC</sub> = 5.5 V,	Eight bits switching at f <sub>1</sub> = 2.5 MHz	$V_{IN}$ = 3.4 V or GND		1	2.4				
	$\frac{\text{Outputs open,}}{\text{OE}_{A} = \text{OE}_{B} = \text{GND}}$				1.3	2.6				
۱ <sub>C</sub> #			$V_{IN}$ = 3.4 V or GND		3.3	10.6ll				~^
'C"		One bit switching at f <sub>1</sub> = 10 MHz	$\begin{array}{l} V_{IN} \leq 0.2 \ V \ or \\ V_{IN} \geq V_{CC} - 0.2 \ V \end{array}$					0.7	1.4	mA
	V <sub>CC</sub> = 5.25 V,	at 50% duty cycle	$V_{IN}$ = 3.4 V or GND					1	2.4	
	$\begin{array}{l} \hline Outputs open, \\ OE_A = OE_B = GND \\ \hline switching \\$		$\begin{array}{l} V_{IN=0.2 \ V \ or} \\ V_{IN\geq V_{CC}-0.2 \ V} \end{array}$					1.3	2.6	
		at f <sub>1</sub> = 2.5 MHz at 50% duty cycle	$V_{IN}$ = 3.4 V or GND					3.3	10.6ll	
Ci					5	10		5	10	pF
Co					9	12		9	12	pF

<sup>†</sup> Typical values are at  $V_{CC} = 5 V$ ,  $T_A = 25^{\circ}C$ .

<sup>#</sup>IC = I<sub>CC</sub> +  $\Delta$ I<sub>CC</sub> × D<sub>H</sub> × N<sub>T</sub> + I<sub>CCD</sub> (f<sub>0</sub>/2 + f<sub>1</sub> × N<sub>1</sub>)

Where:

= Total supply current IC

ICC = Power-supply current with CMOS input levels

 $\Delta I_{CC}$  = Power-supply current for a TTL high input (V<sub>IN</sub> = 3.4 V)

I<sub>CCD</sub> = Dynamic current caused by an input transition pair (HLH or LHL)

fo = Clock frequency for registered devices, otherwise zero

= Input signal frequency f1

= Number of inputs changing at f1  $N_1$ 

All currents are in milliamperes and all frequencies are in megahertz.

I Values for these conditions are examples of the ICC formula.



# CY54FCT244T, CY74FCT244T **8-BIT BUFFERS/LINE DRIVERS** WITH 3-STATE OUTPUTS SCCS071 - OCTOBER 2001

### switching characteristics over operating free-air temperature range (see Figure 1)

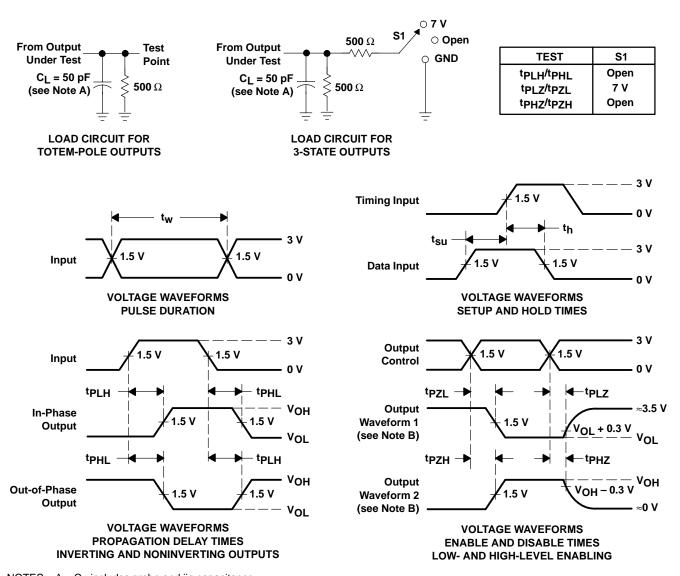
PARAMETER	FROM	то	CY54FC	T244T	CY54FCT	244AT	CY54FCT	244CT	UNIT
PARAMETER	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
<sup>t</sup> PLH	D	о	1.5	7	1.5	5.1	1.5	4.6	ns
<sup>t</sup> PHL	D	0	1.5	7	1.5	5.1	1.5	4.6	115
<sup>t</sup> PZH	OE	о	1.5	8.5	1.5	6.5	1.5	6.5	
<sup>t</sup> PZL	UE	0	1.5	8.5	1.5	6.5	1.5	6.5	ns
<sup>t</sup> PHZ	OE	0	1.5	7.5	1.5	5.9	1.5	5.7	
<sup>t</sup> PLZ	UE	0	1.5	7.5	1.5	5.9	1.5	5.7	ns

### switching characteristics over operating free-air temperature range (see Figure 1)

PARAMETER FROM		то	CY74FCT244T		CY74FCT244AT		CY74FCT244CT		CY74FCT244DT		UNIT
PARAMETER	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
<sup>t</sup> PLH	D	0	1.5	6.5	1.5	4.6	1.5	4.1	1.5	3.6	
<sup>t</sup> PHL	U	0	1.5	6.5	1.5	4.6	1.5	4.1	1.5	3.6	ns
<sup>t</sup> PZH	OE	0	1.5	8	1.5	6.2	1.5	5.8	1.5	4.8	ns
<sup>t</sup> PZL	UE	0	1.5	8	1.5	6.2	1.5	5.8	1.5	4.8	
<sup>t</sup> PHZ	OE	0	1.5	7	1.5	5.6	1.5	5.2	1.5	4	ns
<sup>t</sup> PLZ	UE UE	U	1.5	7	1.5	5.6	1.5	5.2	1.5	4	115



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PARAMETER MEASUREMENT INFORMATION

- NOTES: A.  $C_L$  includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
    C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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### **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
5962-9220301M2A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type
5962-9220301MRA	ACTIVE	CDIP	J	20	1	TBD	A42 SNPB	N / A for Pkg Type
5962-9220301MSA	ACTIVE	CFP	W	20	1	TBD	A42	N / A for Pkg Type
5962-9220302M2A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type
5962-9220302MRA	ACTIVE	CDIP	J	20	1	TBD	A42 SNPB	N / A for Pkg Type
5962-9220302MSA	ACTIVE	CFP	W	20	1	TBD	A42	N / A for Pkg Type
5962-9220303M2A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type
5962-9220303MRA	ACTIVE	CDIP	J	20	1	TBD	A42 SNPB	N / A for Pkg Type
5962-9220303MSA	ACTIVE	CFP	W	20	1	TBD	A42	N / A for Pkg Type
CY54FCT244ATDMB	ACTIVE	CDIP	J	20	1	TBD	A42 SNPB	N / A for Pkg Type
CY54FCT244ATLMB	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type
CY54FCT244ATW	ACTIVE	CFP	W	20	1	TBD	A42	N / A for Pkg Type
CY54FCT244CTDMB	ACTIVE	CDIP	J	20	1	TBD	A42 SNPB	N / A for Pkg Type
CY54FCT244CTW	ACTIVE	CFP	W	20	1	TBD	A42	N / A for Pkg Type
CY54FCT244TDMB	ACTIVE	CDIP	J	20	1	TBD	A42 SNPB	N / A for Pkg Type
CY54FCT244TLMB	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type
CY54FCT244TW	ACTIVE	CFP	W	20	1	TBD	A42	N / A for Pkg Type
CY74FCT244ATPC	ACTIVE	PDIP	Ν	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
CY74FCT244ATPCE4	ACTIVE	PDIP	Ν	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
CY74FCT244ATQCT	ACTIVE	SSOP/ QSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR
CY74FCT244ATQCTE4	ACTIVE	SSOP/ QSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR
CY74FCT244ATQCTG4	ACTIVE	SSOP/ QSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR
CY74FCT244ATSOC	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT244ATSOCE4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT244ATSOCT	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT244ATSOCTE4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT244CTQCT	ACTIVE	SSOP/ QSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR
CY74FCT244CTQCTE4	ACTIVE	SSOP/ QSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR
CY74FCT244CTQCTG4	ACTIVE	SSOP/ QSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR
CY74FCT244CTSOC	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT244CTSOCE4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT244CTSOCT	ACTIVE	SOIC	DW	20	2000	Green (RoHS &	CU NIPDAU	Level-1-260C-UNLIM

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Packag Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
						no Sb/Br)		
CY74FCT244DTQCT	ACTIVE	SSOP/ QSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR
CY74FCT244DTQCTE4	ACTIVE	SSOP/ QSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR
CY74FCT244DTQCTG4	ACTIVE	SSOP/ QSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR
CY74FCT244DTSOC	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT244DTSOCE4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT244DTSOCT	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT244DTSOCTE4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT244TQCT	ACTIVE	SSOP/ QSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR
CY74FCT244TQCTG4	ACTIVE	SSOP/ QSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR
CY74FCT244TSOC	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT244TSOCE4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT244TSOCT	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT244TSOCTE4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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# PACKAGE OPTION ADDENDUM



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J (R-GDIP-T\*\*) 14 LEADS SHOWN

CERAMIC DUAL IN-LINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

W (R-GDFP-F20)

CERAMIC DUAL FLATPACK



- NOTES: A. All linear dimensions are in inches (millimeters).
  - B. This drawing is subject to change without notice.
  - C. This package can be hermetically sealed with a ceramic lid using glass frit.
  - D. Index point is provided on cap for terminal identification only.
  - E. Falls within Mil-Std 1835 GDFP2-F20



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### FK (S-CQCC-N\*\*)

#### LEADLESS CERAMIC CHIP CARRIER

28 TERMINAL SHOWN



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a metal lid.
- D. The terminals are gold plated.
- E. Falls within JEDEC MS-004



# N (R-PDIP-T\*\*)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- $\triangle$  The 20 pin end lead shoulder width is a vendor option, either half or full width.



DW (R-PDSO-G20)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

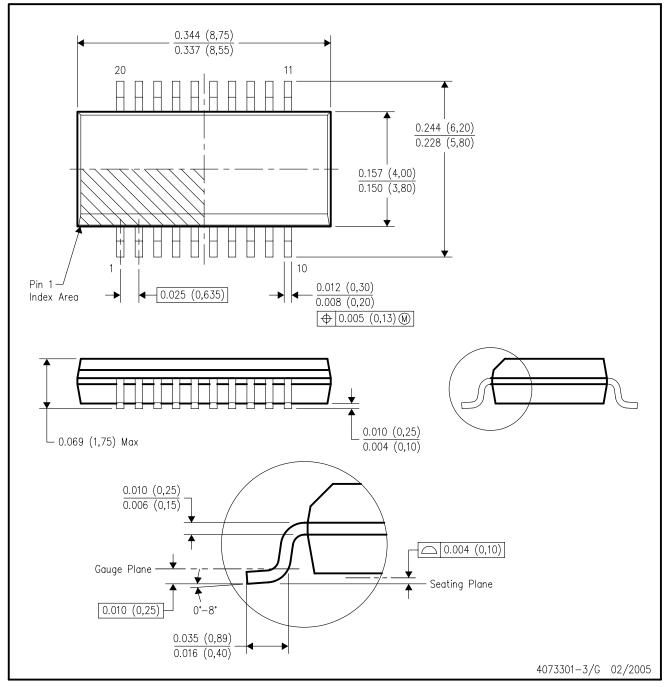
C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-013 variation AC.



DBQ (R-PDSO-G20)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15) per side.

D. Falls within JEDEC MO-137 variation AD.



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